- Complete PWM Power Control Circuitry
- Uncommitted Outputs for 200-mA Sink or Source Current
- Output Control Selects Single-Ended or Push-Pull Operation
- Internal Circuitry Prohibits Double Pulse at Either Output
- Variable Dead Time Provides Control Over Total Range
- Internal Regulator Provides a Stable 5-V Reference Supply Trimmed to 1%
- Circuit Architecture Allows Easy Synchronization
- Undervoltage Lockout for Low V<sub>CC</sub> Conditions

## description

The TL594 incorporates on a single monolithic chip all the functions required in the construction

of a pulse-width-modulation control circuit. Designed primarily for power supply control, these devices offer the systems engineer the flexibility to tailor the power supply control circuitry to a specific application.

The TL594 contains two error amplifiers, an on-chip adjustable oscillator, a dead-time control (DTC) comparator, a pulse-steering control flip-flop, a 5-V regulator with a precision of 1%, an undervoltage lockout control circuit, and output control circuitry.

The error amplifiers exhibit a common-mode voltage range from  $-0.3\,\mathrm{V}$  to  $\mathrm{V}_{\mathrm{CC}}-2\,\mathrm{V}$ . The DTC comparator has a fixed offset that provides approximately 5% dead time. The on-chip oscillator may be bypassed by terminating RT to the reference output and providing a sawtooth input to CT, or it may be used to drive the common circuitry in synchronous multiple-rail power supplies.

The uncommitted output transistors provide either common-emitter or emitter-follower output capability. Each device provides for push-pull or single-ended output operation with selection by means of the output-control function. The architecture of these devices prohibits the possibility of either output being pulsed twice during push-pull operation. The undervoltage lockout control circuit locks the outputs off until the internal circuitry is operational.

The TL594C is characterized for operation from  $0^{\circ}$ C to  $70^{\circ}$ C. The TL594I is characterized for operation from  $-40^{\circ}$ C to  $85^{\circ}$ C.

#### D OR N PACKAGE (TOP VIEW) 16 1 2IN+ 15 2IN-1IN-FEEDBACK I 14 REF DTC 13 OUTPUT CTRL 12 VCC CT RT 11 C2 6 GND [ 10 **∏** E2 C1 9 **∏** E1

#### **FUNCTION TABLE**

INPUT OUTPUT CTRL	OUTPUT FUNCTION
$V_I = 0$	Single-ended or parallel output
$V_I = V_{ref}$	Normal push-pull operation

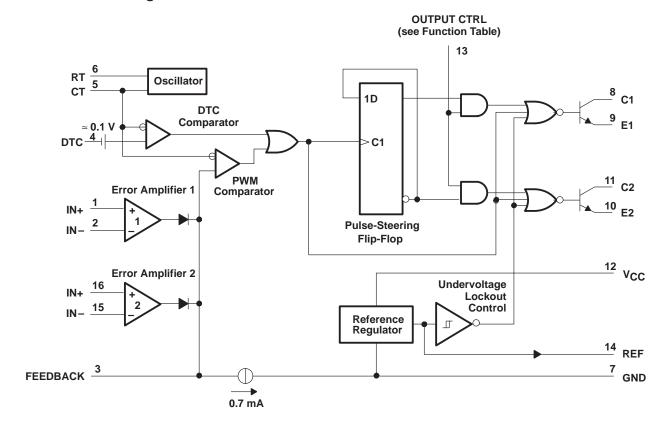
## AVAILABLE OPTIONS

	PACKAGED I	DEVICES	CHIP FORM
TA	SMALL OUTLINE† (D)	PLASTIC DIP (N)	(Y)
0°C to 70°C	TL594CD	TL594CN	TL594Y
-40°C to 85°C	TL594ID	TL594IN	1113941

<sup>†</sup> The D package is available taped and reeled. Add "R" suffix to device type (e.g., TL594CDR).

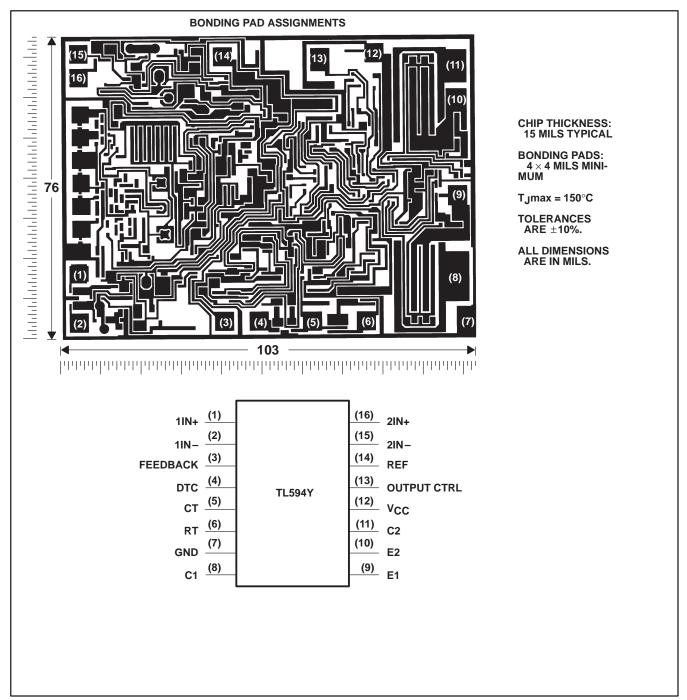


## functional block diagram



## **TL594Y chip information**

This chip, when properly assembled, displays characteristics similar to the TL594C (see electrical tables). Thermal compression or ultrasonic bonding can be used on the doped aluminum bonding pads. The chip can be mounted with conductive epoxy or a gold-silicon preform.



# TL594C, TL594I, TL594Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

	TL594C	TL594I	UNIT	
Supply voltage, V <sub>CC</sub> (see Note 1)	41	41	V	
Amplifier input voltage	V <sub>CC</sub> +0.3	V <sub>CC</sub> +0.3	V	
Collector output voltage	41	41	V	
Collector output current	250	250	mA	
Continuous total dissipation	See Dis	See Dissipation Rating Table		
Operating free-air temperature range, TA	0 to 70	-40 to 85	°C	
Storage temperature range, T <sub>stg</sub>	-65 to 150	-65 to 150	°C	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260	260	°C	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values, except differential voltages, are with respect to the network ground terminal.

#### **DISSIPATION RATING TABLE**

PACKAGE	$T_{\mbox{\scriptsize A}} \le 25^{\circ}\mbox{\scriptsize C}$ POWER RATING	DERATING FACTOR	DERATE ABOVE T <sub>A</sub>	T <sub>A</sub> = 70°C POWER RATING	T <sub>A</sub> = 85°C POWER RATING
D	950 mW	7.6 mW/°C	25°C	608 mW	494 mW
N	1000 mW	9.2 mW/°C	41°C	733 mW	595 mW

## recommended operating conditions

		TL59	4C	TL594I		
	Γ	MIN	MAX	MIN	MAX	UNIT
Supply voltage, V <sub>CC</sub>		7	40	7	40	V
Amplifier input voltage, V <sub>I</sub>		-0.3	V <sub>CC</sub> -2	-0.3	V <sub>CC</sub> -2	V
Collector output voltage, VO			40		40	V
Collector output current (each transistor)			200		200	mA
Current into feedback terminal			0.3		0.3	mA
Timing capacitor, C <sub>T</sub>		0.47	10 000	0.47	10 000	nF
Timing resistor, R <sub>T</sub>		1.8	500	1.8	500	kΩ
Oscillator frequency, f <sub>OSC</sub>		1	300	1	300	kHz
Operating free-air temperature, TA		0	70	-40	85	°C

# electrical characteristics over recommended operating conditions, $V_{CC}$ = 15 V, (unless otherwise noted)

#### reference section

PARAMETER	TEST CONDIT	TL594C, TL594I			UNIT	
FARAMETER	TEST CONDIT	MIN	TYP‡	MAX	UNIT	
Output voltage (REF)	$I_O = 1 \text{ mA},$	T <sub>A</sub> = 25°C	4.95	5	5.05	V
Input regulation	$V_{CC} = 7 \text{ V to } 40 \text{ V},$	T <sub>A</sub> = 25°C		2	25	mV
Output regulation	$I_O = 1$ to 10 mA,	T <sub>A</sub> = 25°C		14	35	mV
Output voltage change with temperature	$\Delta T_A = MIN \text{ to MAX}$			2	10	mV/V
Short-circuit output current§	$V_{ref} = 0$		10	35	50	mA

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## amplifier section (see Figure 1)

DADAMETED	TEST CONDITIONS			TL594C, TL594I			
PARAMETER	"=	MIN	TYP <sup>†</sup>	MAX	UNIT		
Input offset voltage, error amplifier	FEEDBACK = 2.5 V				2	10	mV
Input offset current	FEEDBACK = 2.5 V				25	250	nA
Input bias current	FEEDBACK = 2.5 V				0.2	1	μΑ
Common-mode input voltage range, error amplifier	V <sub>CC</sub> = 7 V to 40 V			0.3 to V <sub>CC</sub> -	2		V
Open-loop voltage amplification, error amplifier	$\Delta V_{O} = 3 V$ ,	$R_L = 2 k\Omega$ ,	$V_0 = 0.5 \text{ V to } 3.5 \text{ V}$	70	95		dB
Unity-gain bandwidth	$V_0 = 0.5 \text{ V to } 3.5 \text{ V},$	$R_L = 2 k\Omega$			800		kHz
Common-mode rejection ratio, error amplifier	V <sub>CC</sub> = 40 V,	T <sub>A</sub> = 25°C		65	80		dB
Output sink current, FEEDBACK	$V_{ID} = -15 \text{ mV to } -5 \text{ V},$	FEEDBACK =	0.5 V	0.3	0.7		mA
Output source current, FEEDBACK	$V_{ID}$ = 15 mV to 5 V,	FEEDBACK =	3.5 V	-2			mA

<sup>†</sup> All typical values except for parameter changes with temperature are at  $T_A = 25^{\circ}$ C.

## oscillator section, $C_T$ = 0.01 $\mu$ F, $R_T$ = 12 $k\Omega$ (see Figure 2)

PARAMETER	TEST CONDITIONS†	TL59	UNIT		
PARAMETER	TEST CONDITIONS!	MIN	TYP‡	MAX	UNIT
Frequency			10		kHz
Standard deviation of frequency§	All values of V <sub>CC</sub> , C <sub>T</sub> , R <sub>T</sub> , and T <sub>A</sub> constant		100		Hz/kHz
Frequency change with voltage	$V_{CC} = 7 \text{ V to } 40 \text{ V},  T_A = 25^{\circ}\text{C}$		1		Hz/kHz
Frequency change with temperature¶	$\Delta T_A = MIN \text{ to MAX}$			50	Hz/kHz

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

$$\sigma = \sqrt{\frac{\sum_{n=1}^{N} (x_n - \overline{X})^2}{N-1}}$$

<sup>‡</sup> All typical values except for parameter changes with temperature are at T<sub>A</sub> = 25°C.

<sup>§</sup> Duration of the short circuit should not exceed one second.

<sup>‡</sup> All typical values except for parameter changes with temperature are at  $T_A = 25$ °C.

<sup>§</sup> Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

<sup>¶</sup> Temperature coefficient of timing capacitor and timing resistor not taken into account.

# TL594C, TL594I, TL594Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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## electrical characteristics over recommended operating free-air temperature range, V<sub>CC</sub> = 15 V, (unless otherwise noted)

## dead-time control section (see Figure 2)

PARAMETER	TEST CONDITIONS	TL5	UNIT		
PARAMETER	$V_{I} = 0 \text{ to } 5.25 \text{ V}$ $-2 -10 \mu A$	UNII			
Input bias current	V <sub>I</sub> = 0 to 5.25 V		-2	-10	μΑ
Maximum duty cycle, each output	DTC = 0 V	0.45			
Input threshold voltage	Zero duty cycle		3	3.3	V
Imput unconoid voitage	Maximum duty cycle	0			٧

<sup>†</sup> All typical values except for parameter changes with temperature are at T<sub>A</sub> = 25°C.

## output section

DADAMETED		TEST CONDITIONS		TL59	LINIT		
PARAMETER		TEST CONDITIONS MIN TYPT MAX		† MAX UNIT			
		$V_C = 40 \text{ V}, V_E = 0 \text{ V},$	$V_{CC} = 40 \text{ V}$		2	100	
Collector off-state current		DTC and OUTPUT CTF $V_C = 15 \text{ V},$ $V_{CC} = 1 \text{ to } 3 \text{ V}$	RL = 0 V, $V_E = 0 V,$		4	200	μΑ
Emitter off-state current		$V_{CC} = V_{C} = 40 \text{ V},$	V <sub>E</sub> = 0			-100	μΑ
Collector-emitter saturation voltage	Common emitter	V <sub>E</sub> = 0,	$I_C = 200 \text{ mA}$		1.1	1.3	V
Collector-entitler saturation voltage	Emitter follower	$V_C = 15 V$ ,	$I_E = -200 \text{ mA}$		1.5	2.5	V
Output control input current	·	$V_I = V_{ref}$	_			3.5	mA

 $<sup>^\</sup>dagger$  All typical values except for parameter changes with temperature are at T<sub>A</sub> = 25°C.

## pwm comparator section (see Figure 2)

PARAMETER	TEST CONDITIONS	TL59	UNIT		
PARAMETER	TEST CONDITIONS	MIN	TYP <sup>†</sup>	MAX	UNII
Input threshold voltage, FEEDBACK	Zero duty cycle		4	4.5	V
Input sink current, FEEDBACK	FEEDBACK = 0.5 V	0.3	0.7		mA

<sup>&</sup>lt;sup>†</sup> All typical values except for parameter changes with temperature are at  $T_A = 25$ °C.

## undervoltage lockout section (see Figure 2)

PARAMETER	TEST CONDITIONST	TL594C,	UNIT	
PARAMETER	TEST CONDITIONS:	MIN	MAX	UNII
Throchold voltage	T <sub>A</sub> = 25°C		6	1/
Threshold voltage	$\Delta T_A = MIN \text{ to MAX}$	3.5	6.9	V
Hysteresis <sup>‡</sup>		100		mV

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## total device (see Figure 2)

PARAMETER	TEST CONDITIONS		TL5	UNIT		
PARAMETER			MIN	TYP†	MAX	UNII
Standby supply current	RT at V <sub>ref</sub> ,	V <sub>CC</sub> = 15 V		9	15	A
	All other inputs and outputs open	V <sub>CC</sub> = 40 V		11	18	mA
Average supply current	DTC = 2 V,	See Figure 2		12.4		mA

<sup>†</sup> All typical values except for parameter changes with temperature are at T<sub>A</sub> = 25°C.



<sup>‡</sup> Hysteresis is the difference between the positive-going input threshold voltage and the negative-going input threshold voltage.

electrical characteristics over recommended operating free-air temperature range,  $V_{CC} = 15 \text{ V}$ , (unless otherwise noted) (continued)

# switching characteristics, $T_A = 25^{\circ}C$

PARAMETER	TEST CONDITIONS		TL594C, TL594I			
PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT	
Output voltage rise time	Common emitter configuration Con Figure 2		100	200	ns	
Output voltage fall time	Common-emitter configuration, See Figure 3		30	100	ns	
Output voltage rise time	Emitter-follower configuration, See Figure 4		200	400	ns	
Output voltage fall time	Emilier-follower comiguration, See Figure 4		45	100	ns	

<sup>&</sup>lt;sup>†</sup> All typical values except for parameter changes with temperature are at  $T_A = 25$ °C.

# electrical characteristics over recommended operating conditions, $V_{CC}$ = 15 V, $T_A$ = 25°C (unless otherwise noted)

### reference section

PARAMETER	TEST CONDITIONS	7	UNIT		
PARAWETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output voltage (REF)	I <sub>O</sub> = 1 mA,		5		V
Input regulation	$V_{CC} = 7 \text{ V to } 40 \text{ V},$		2		mV
Output regulation	I <sub>O</sub> = 1 to 10 mA,		14		mV
Short-circuit output current <sup>†</sup>	V <sub>ref</sub> = 0		35		mA

<sup>†</sup> Duration of the short circuit should not exceed one second.

## oscillator section, $C_T$ = 0.01 $\mu$ F, $R_T$ = 12 $k\Omega$ (see Figure 2)

PARAMETER	TEST CONDITIONS	1	UNIT		
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Frequency			10		kHz
Standard deviation of frequency†	All values of V <sub>CC</sub> , C <sub>T</sub> , R <sub>T</sub> , and T <sub>A</sub> constant		100		Hz/kHz
Frequency change with voltage	$V_{CC} = 7 \text{ V to } 40 \text{ V},$		1		Hz/kHz

<sup>†</sup> Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

$$\sigma = \sqrt{\frac{\sum_{n=1}^{N} (x_n - \overline{X})^2}{N-1}}$$

## amplifier section (see Figure 1)

PARAMETER	TEST CONDITIONS			TL594Y			UNIT
PARAMETER TEST CONDITIONS			MIN	TYP	MAX	UNII	
Input offset voltage, error amplifier	FEEDBACK = 2.5 V				2		mV
Input offset current	FEEDBACK = 2.5 V				25		nA
Input bias current	FEEDBACK = 2.5 V				0.2		μΑ
Open-loop voltage amplification, error amplifier	$\Delta V_{O} = 3 V$ ,	$R_L = 2 k\Omega$ ,	$V_0 = 0.5 \text{ V to } 3.5 \text{ V}$		95		dB
Unity-gain bandwidth	$V_0 = 0.5 \text{ V to } 3.5 \text{ V},$	$R_L = 2 k\Omega$			800		kHz
Common-mode rejection ratio, error amplifier	V <sub>CC</sub> = 40 V,	T <sub>A</sub> = 25°C			80		dB
Output sink current, FEEDBACK	$V_{ID} = -15 \text{ mV to } -5 \text{ V},$	FEEDBACK =	0.5 V		0.7		mA

# TL594C, TL594I, TL594Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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electrical characteristics over recommended operating free-air temperature range,  $V_{CC}$  = 15 V,  $T_A$  = 25°C (unless otherwise noted)

## dead-time control section (see Figure 2)

PARAMETER	TEST CONDITIONS	٦	UNIT		
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNII
Input bias current	V <sub>I</sub> = 0 to 5.25 V		-2		μΑ
Input threshold voltage	Zero duty cycle		3		V

## output section

PARAMETER		TEST CONDITIONS			LINIT		
				MIN	TYP†	MAX	UNIT
		$V_C = 40 \text{ V}, V_E = 0 \text{ V},$	$V_{CC} = 40 \text{ V}$		2		
		DTC and OUTPUT CT V <sub>C</sub> = 15 V, V <sub>CC</sub> = 1 to 3 V	RL = 0 V, V <sub>E</sub> = 0 V,		4		μΑ
Emitter off-state current		$V_{CC} = V_C = 40 \text{ V},$	V <sub>E</sub> = 0				μΑ
Collector-emitter saturation voltage	Common emitter	VE = 0,	$I_C = 200 \text{ mA}$		1.1		V
	Emitter follower	$V_C = 15 V$ ,	$I_E = -200 \text{ mA}$		1.5		V

## pwm comparator section (see Figure 2)

PARAMETER	TEST CONDITIONS	٦	UNIT		
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNII
Input threshold voltage, FEEDBACK	Zero duty cycle		4		V
Input sink current, FEEDBACK	FEEDBACK = 0.5 V		0.7		mA

## total device (see Figure 2)

PARAMETER	TEST CONDITIONS			TL594Y			
PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT	
Standby supply current	All other inputs and outputs open	R <sub>T</sub> at V <sub>ref</sub> ,		9		mA	
Average supply current	DTC = 2 V,	See Figure 2		12.4		mA	

# switching characteristics, $T_A = 25^{\circ}C$

PARAMETER	TEST CONDITIONS		TL594Y			
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Output voltage rise time	Common amittar configuration — Con Figure 2		100		ns	
Output voltage fall time	Common-emitter configuration, See Figure 3		30		ns	
Output voltage rise time	Emitter-follower configuration, See Figure 4		200		ns	
Output voltage fall time	Emitter-follower configuration, See Figure 4		45		ns	

## PARAMETER MEASUREMENT INFORMATION

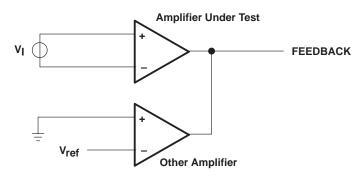


Figure 1. Amplifier Characteristics Test Circuit

#### PARAMETER MEASUREMENT INFORMATION V<sub>CC</sub> = 15 V 150 150 12 Ω Ω **VCC** 2 W 2 W DTC C1 Output 1 Test Inputs 9 **FEEDBACK** E1 **12 k**Ω TL594 6 11 C2 Output 2 RT 10 СТ E2 0.01 μF 1 IN+ 2 Error IN-16 **Amplifiers** IN+ 15 IN-13 OUTPUT 14 **REF CTRL GND** 50 k $\Omega$ 7

**TEST CIRCUIT** 

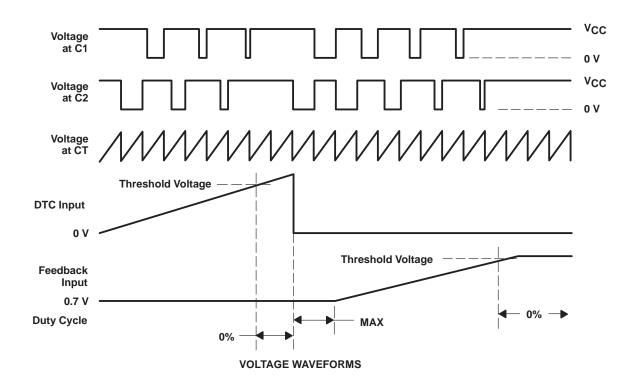


Figure 2. Operational Test Circuit and Waveforms



## PARAMETER MEASUREMENT INFORMATION

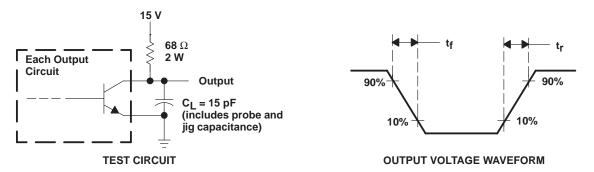


Figure 3. Common-Emitter Configuration

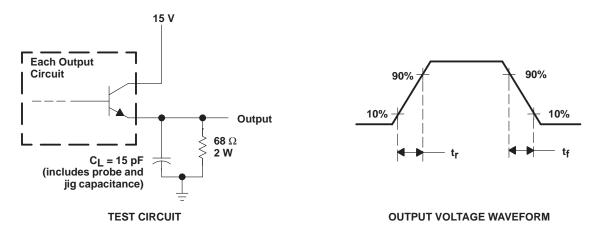


Figure 4. Emitter-Follower Configuration

## **TYPICAL CHARACTERISTICS**

# OSCILLATOR FREQUENCY AND FREQUENCY VARIATION †

# TIMING RESISTANCE

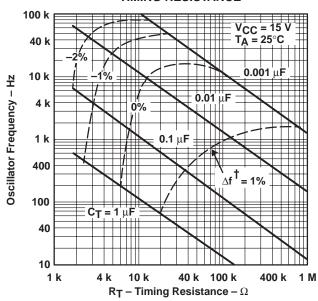
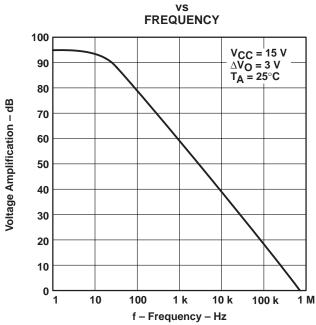


Figure 5

### **AMPLIFIER VOLTAGE AMPLIFICATION**



† Frequency variation ( $\Delta f$ ) is the change in oscillator frequency that occurs over the full temperature range.

Figure 6

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